## What Is Claimed Is:

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1. A method for activating a microprocessor arranged as a part of a microcontroller, within a framework of a boundary scan test procedure according to IEEE standard 1149, in accordance with a JTAG interface, comprising the step of:

activating the JTAG interface of the microprocessor in accordance with a test routine that is executable on the microprocessor.

2. The method according to claim 1, wherein I/O ports of the microprocessor are connected to pins of the JTAG interface, the method further comprising the step of: activating the pins of the JTAG interface in accordance with the test routine via the I/O ports.

- 3. The method according to claim 2, further comprising the step of: performing at least one of a setting operation and a reading operation with respect to the pins of the JTAG interface in accordance with a stipulated test sequence in the test routine.
- 4. The method according to claim 1, further comprising the step of:
  causing the test routine to provide a test data stream to the JTAG interface within the
  framework of the boundary scan test procedure.
- 5. The method according to claim 2, further comprising the steps of:
  switching the I/O ports of the microprocessor in accordance with the test routine for a
  predefined duration to output ports and to high; and
  measuring levels present at an interface of the microcontroller.
- 6. The method according to claim 3, further comprising the steps of: switching the I/O ports of the microprocessor in accordance with the test routine for a predefined duration to input ports; and

applying defined values to an interface of the microcontroller in accordance with the stipulated test sequence.



7. The method according to claim 6, further comprising the steps of: reading values present at the pins of the JTAG interface via the I/O ports of the microprocessor; and

storing the values present at the pins of the JTAG interface in a memory area of the microcontroller.

- 8. The method according to claim 7, further comprising the step of: reading out the values present at the pins of the JTAG interface and stored in the memory area via the interface of the microcontroller.
- 9. The method according to claim 1, wherein: the microcontroller is arranged in a control unit of a motor vehicle.
- 10. A microcontroller, comprising:

at least one microprocessor capable of being activated, within a framework of a boundary scan test procedure according to IEEE standard 1149, by a JTAG interface of the at least one microprocessor, wherein:

the at least one microprocessor includes an arrangement for activating the JTAG interface by a test routine capable of being executed on the at least one microprocessor.

11. The microcontroller according to claim 10, wherein:

the arrangement includes PAD cells of the microprocessor and connecting leads from the PAD cells to pins of the JTAG interface, the PAD cells including an input/output port function.

12. The microcontroller according to claim 10, wherein:

the microcontroller includes an interface, wherein one of levels present can be measured and defined values can be applied from outside the microcontroller.